

Data sheet acquired from Harris Semiconductor SCHS039C – Revised September 2003

CMOS Quad True/Complement Buffer

High Voltage Types (20-Volt Rating)

complement buffers consisting of n- and p-channel units having low channel resistance and high current (sourcing and sinking) capability. The CD4041UB is intended for use as a buffer, line driver, or CMOS-to-TTL driver, it can be used as an ultra-low power resistor-network driver for A/D and D/A conversion, as a transmission-line driver, and in other applications where high noise immunity and low power dissipation are primary design requirements.

The CD4041UB types are supplied in 14-lead hermetic dual-in-line ceramic packages (F3A suffix), 14-lead dual-in-line plastic packages (E suffix), 14-lead small-outline packages (M, MT, M96, and NSR suffixes), and 14-lead thin shrink small-outline packages (PW and PWR suffixes).

CD4041UB Types

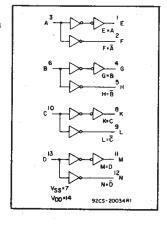
Features:

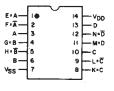
- Balanced sink and source current; approximately 4 times standard "B" drive
- Equalized delay to true and complement outputs
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full package temperature range; 100 nA at 18 V and 25°C
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

tions:

Applications:

- High current source/sink driver
- **CMOS-to-DTL/TTL Converter Buffer**
- Display driver
- MOS clock driver
- Resistor network driver (Ladder or weighted R)
- Buffer
- Transmission line driver





92CS-20755R1

TOP VIEW TERMINAL ASSIGNMENT

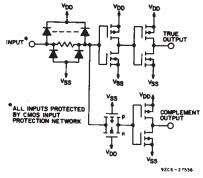


Fig.1 - Schematic diagram 1 of 4 buffers.

MAXIMUM RATINGS, Absolute-Maximum Values: DC SUPPLY-VOLTAGE RANGE. (Von.)

DC SOFFLY-VOLINGE RANGE, (VDD)	
Voltages referenced to VSS Terminal)	
INPUT VOLTAGE RANGE, ALL INPUTS	+0.5V
DC INPUT CURRENT, ANY ONE INPUT	±10mA
POWER DISSIPATION PER PACKAGE (PD):	
For $T_A = -55^{\circ}C$ to $+100^{\circ}C$	500mW
For T _A = +100°C to +125°C	Derate Linearity at 12mW/°C to 200mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	•
FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package	e Types)
OPERATING-TEMPERATURE RANGE (TA)	55°C to +125°C
STORAGE TEMPERATURE RANGE (Tstg)	65°C to +150°C
LEAD TEMPERATURE (DURING SOLDERING):	

RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following range:

CHARACTERISTIC	LIN	MITS	UNITS
	Min.	Max.	
Supply-Voltage Range (For TA=Full Package- Temperature Range)	3	18	v

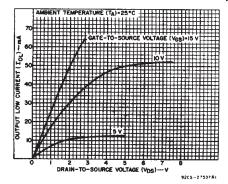


Fig.2 - Typical output low (sink) current characteristics.

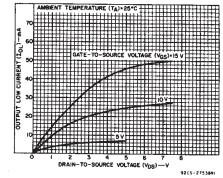


Fig.3 — Minimum low (sink) current characteristics.

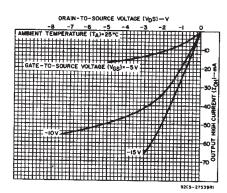


Fig.4 — Typical output high (source) current characteristics.

CD4041UB Types

STATIC ELECTRICAL CHARACTERISTICS

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CHARAC-	CONE	OITION	ıs	LIM	IITS AT	INDICA	MPERA	PERATURES (°C)			
TERISTIC	v _o	VIN	v_{DD}								
	(V)	(V)	(V)	–55	-40	+85	+125	Min.	Тур.	Max.	
Quiescent	_	0,5	5	1	1	30	30	_	0.02	1	
Device		0,10	10	2	.2	60	60	_	0.02	2	μA
Current		0,15	15	4	. 4	120	120	1	0.02	4	μ^
IDD Max.	<u> </u>	0,20	20	20	20	600	600	_	0.04	20	
Output Low											
(Sink)	0.4	0,5	5	2.1	1.8	1.3	1.2	1.6	3.2		
Current,	0.5	0,10	10	6.25	5.6	4	3.5	5	10		
IOL Min.	1.5	0,15	15	24	23	15.5	13	19	38	-	mA
Output High	4.6	0,5	5	-2.1	-1.8	-1.3	-1.2	-1.6	-3.2		''''
(Source)	2.5	0,5	5	-8.4	-6.7	-5.3	-4.6	-6.4	-12.8	<u> </u>	
Current,	9.5	0,10	10	-6.25	-5.6	-4	-3.5	-5	_10		
I _{OH} Min.	13.5	0,15	15	-24	-23	-15.5	–13 ,	-19	-38	_	
Output Volt-					•						
age:		0,5	5		0.0	05		_	0.	0.05	
Low-Level,	-	0,10	10		0.0)5		_	0	0.05	
V _{OL} Max.	_	0,15	15		0.0)5		_	0	0.05] _v
Output Volt-											1 *
age:	l – .i	0,5	5		4.9	95		4.95	5	_	
High-Level,		0,10	10		9.9	95	1. 1	9.95	10	Γ -	1
V _{OH} Min.	_	0,15	15		14.	95		14.95	15	-	
Input Low	0.5,4.5	_	5		-1	l		-	_	1	
Voltage, _	1,9	: -	10		- 2	2		_		2]
V _{IL} Max,	1.5,13.5		15 .		2	.5		_	-	2.5	. v .
Input High	0.5,4.5	. —	5		4				_	-	•
Voltage,	1,9	-	10	8				8	-	_]
V _{IH} Min.	1.5,13.5	_	15	12.5				12.5	_	_	
Input					150				5		
Current,	-	0,18	18	±0.1	±0.1	±1	±1	-	±10 ⁻⁵	±0.1	μΑ
I _{IN} Max.									<u> </u>		

DYNAMIC ELECTRICAL CHARACTERISTICS at TA = 25°C, Input t, tf = 20 ns, CL = 50 pF, RL = 200 k Ω

	COND	ITIONS	LII		
CHARACTERISTIC		V _{DD} Volts	Тур.	Max.	UNITS
Propagation Delay Time:		5	60	120	
tPHL,		10	35	70	ns
^t PLH		15	25	50	1 .
		5	40	80	
Transition Time TTHL		10	20	40	ns
т⊾н	1	15	15	30	
Input Capacitance CIN	Any	Any Input		22.5	pΕ

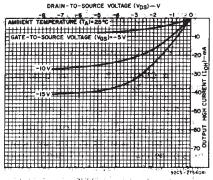


Fig.5 — Minimum output high (source) current characteristics.

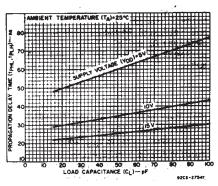


Fig.6 — Typical propagation delay time vs. load capacitance.

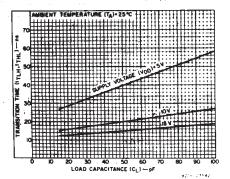


Fig.7 — Typical transition time vs. load capacitance.

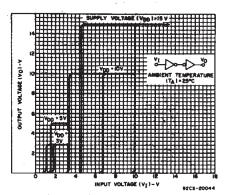


Fig.8 — Minimum and maximum transfer characteristics — true output.

CD4041UB Types

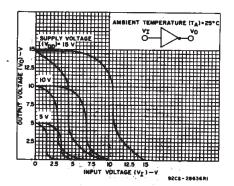


Fig.9 — Minimum and maximum transfer characteristics — complement output,

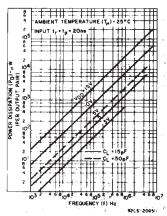


Fig.11 - Typical power dissipation vs frequency per output pair.

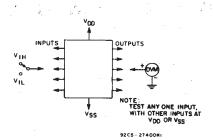


Fig.13 - Input voltage test circuit.

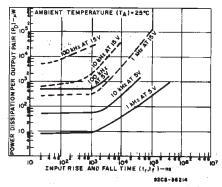


Fig. 10 — Typical power dissipation vs. input rise & fall time per output pair.

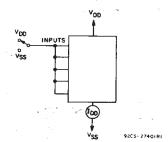


Fig. 12 - Quiescent device current test circuit.

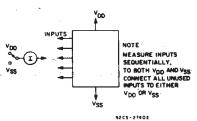
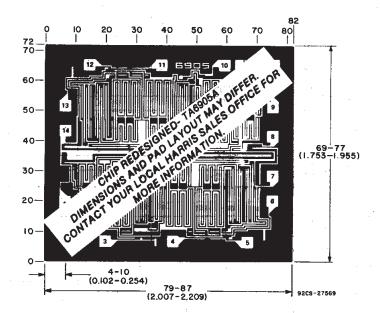


Fig. 14 - Input-leakage-current test circuit.

Dimensions and pad layout for the CD4041UBH



Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated Grid graduations are in mils (10^{-3} inch).

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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
CD4041UBE	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4041UBE	Samples
CD4041UBF	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4041UBF	Samples
CD4041UBF3A	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4041UBF3A	Samples
CD4041UBM	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	-55 to 125	CD4041UBM	
CD4041UBM96	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4041UBM	Samples
CD4041UBMT	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	-55 to 125	CD4041UBM	
CD4041UBPW	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	-55 to 125	CM041UB	
CD4041UBPWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM041UB	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: Til defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

PACKAGE OPTION ADDENDUM

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(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD4041UB, CD4041UB-MIL:

Catalog : CD4041UB

Military: CD4041UB-MIL

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4041UBM96	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CD4041UBPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4041UBM96	SOIC	D	14	2500	356.0	356.0	35.0
CD4041UBPWR	TSSOP	PW	14	2000	356.0	356.0	35.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD4041UBE	N	PDIP	14	25	506	13.97	11230	4.32
CD4041UBE	N	PDIP	14	25	506	13.97	11230	4.32



SMALL OUTLINE INTEGRATED CIRCUIT



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
 Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
 Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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